## Notice of References Cited Application/Control No. 10/772,240 Examiner Quan Tra Applicant(s)/Patent Under Reexamination SHIN, SOON-KYUN Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,734,718	05-2004	Pan, Feng	327/536
*	В	US-6,208,196	03-2001	St. Pierre, Robert	327/536
	С	US-			
	D	US-			
	Ε	US-		·	
	F	US-			
	G	US-	*****		
	Η	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			V-17
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*	<u> </u>	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р			-		-	
	Q					-	
	R						
	S						
	Т						

## **NON-PATENT DOCUMENTS**

_						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.